


<b>Search Notes</b>  	<b>Application/Control No.</b>  10758532	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  Neway, Samuel G	<b>Art Unit</b>  2626

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST: Text, Assignee, Inventor, PLUS, and Forward/Backward Search	06/14/07	SN
NPL Search	06/14/07	SN
Consulted: T. Smits	06/14/07	SN

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>